

032646-03001

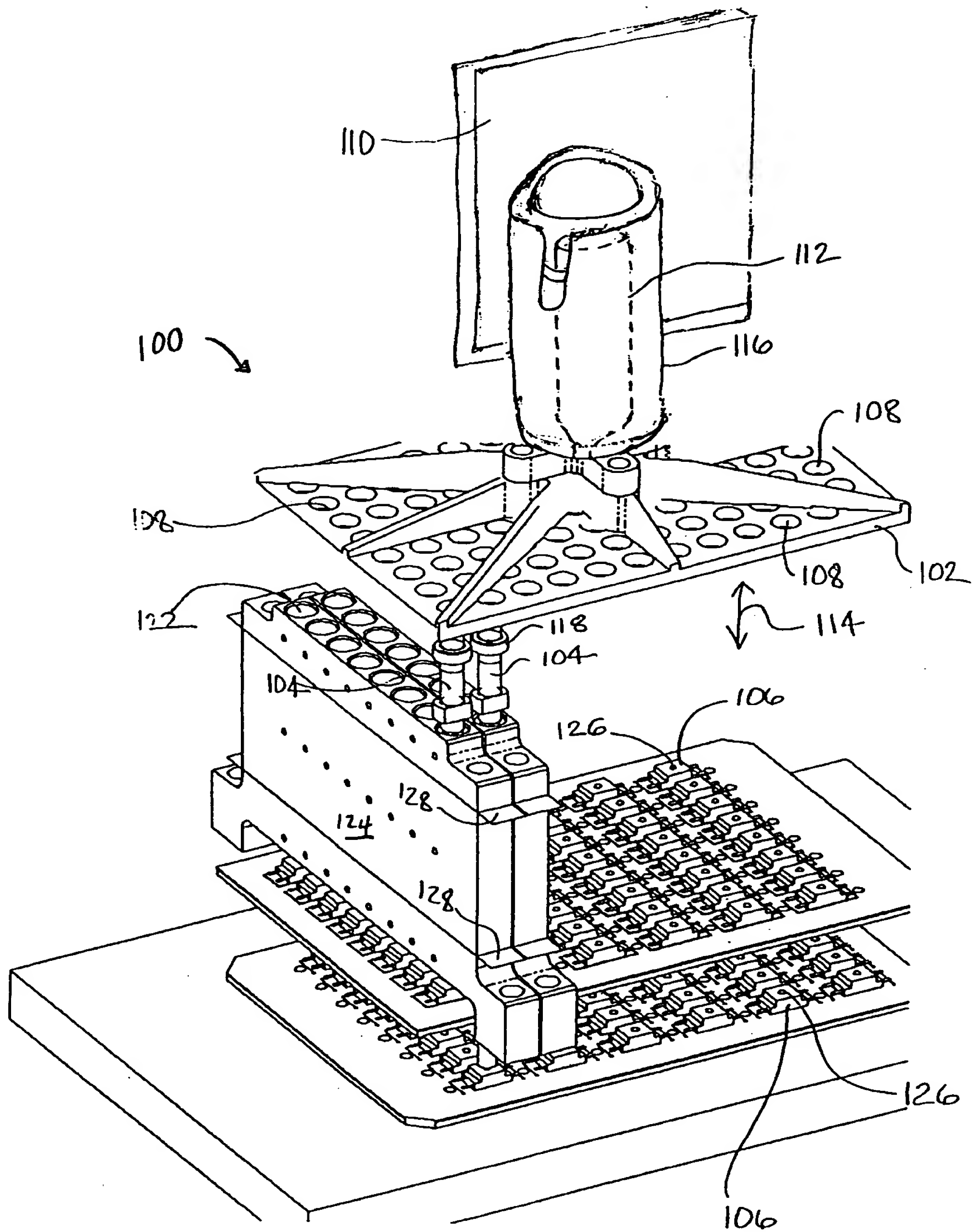
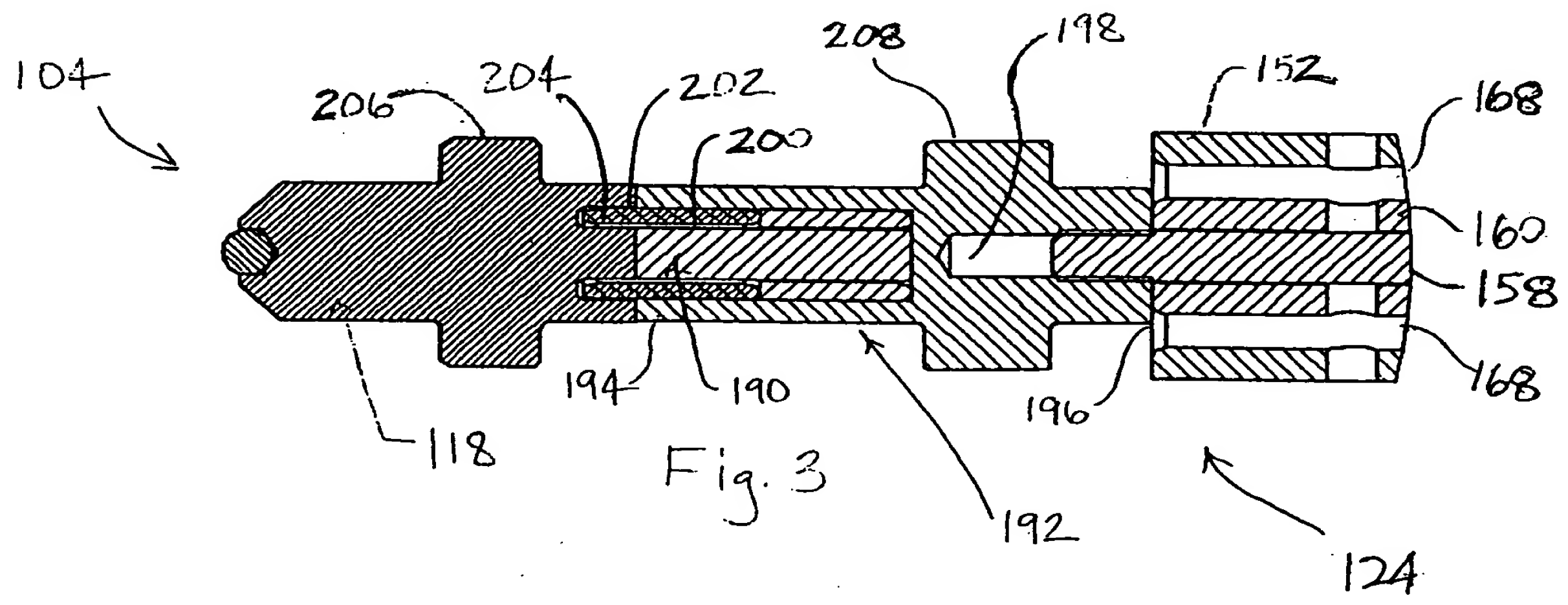
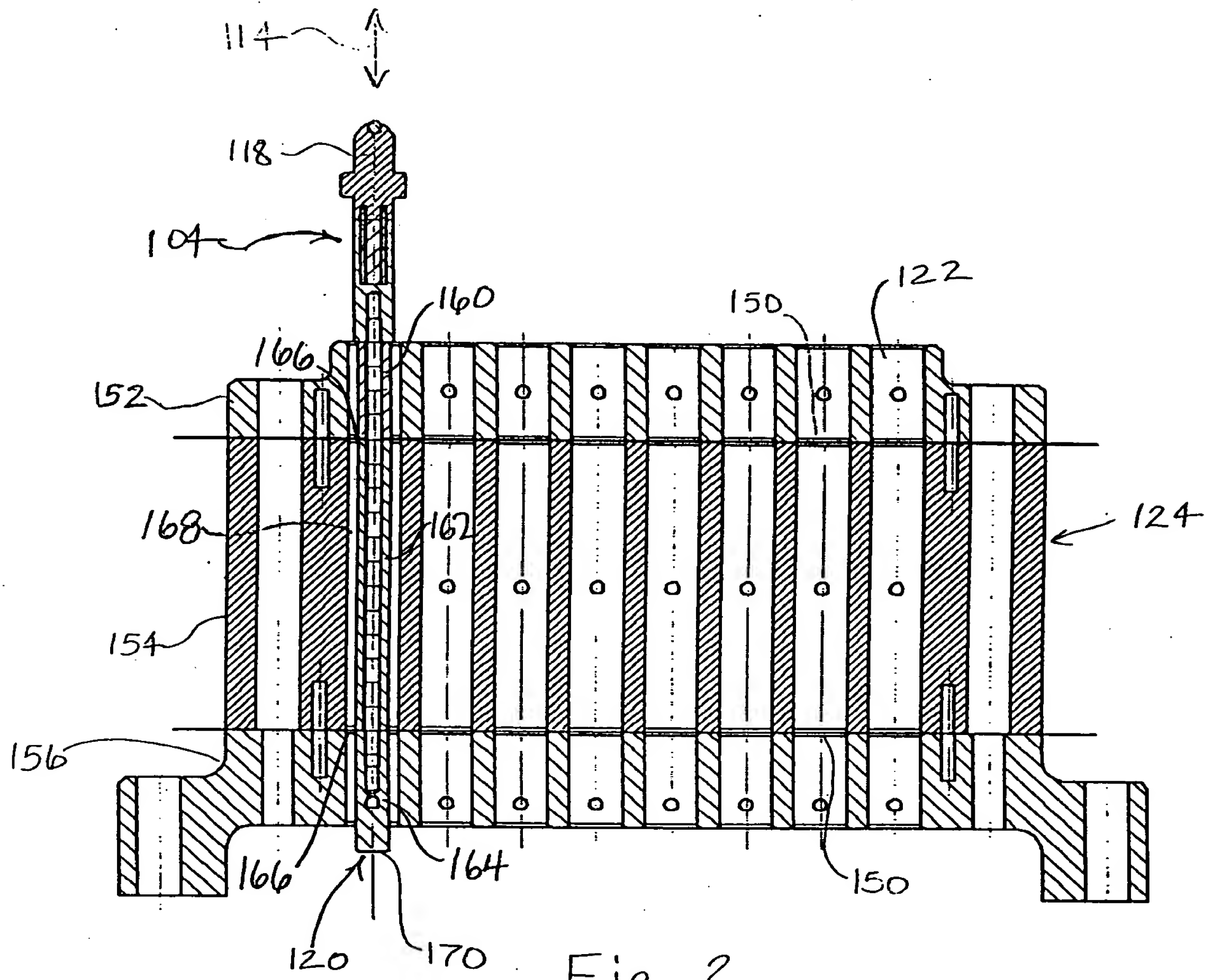


Fig. 1

FIG. 2



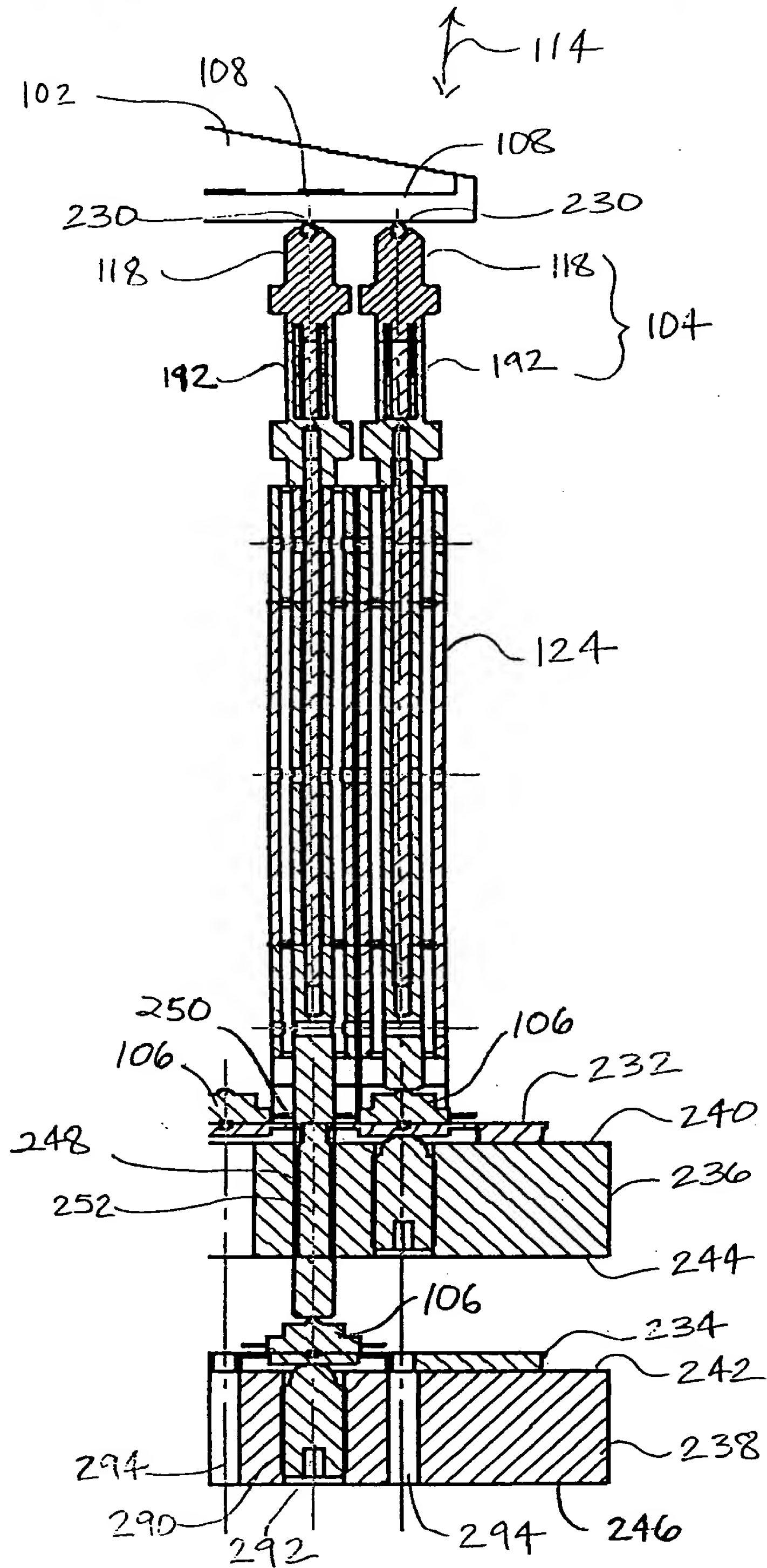


Fig. 4

FIG. 5

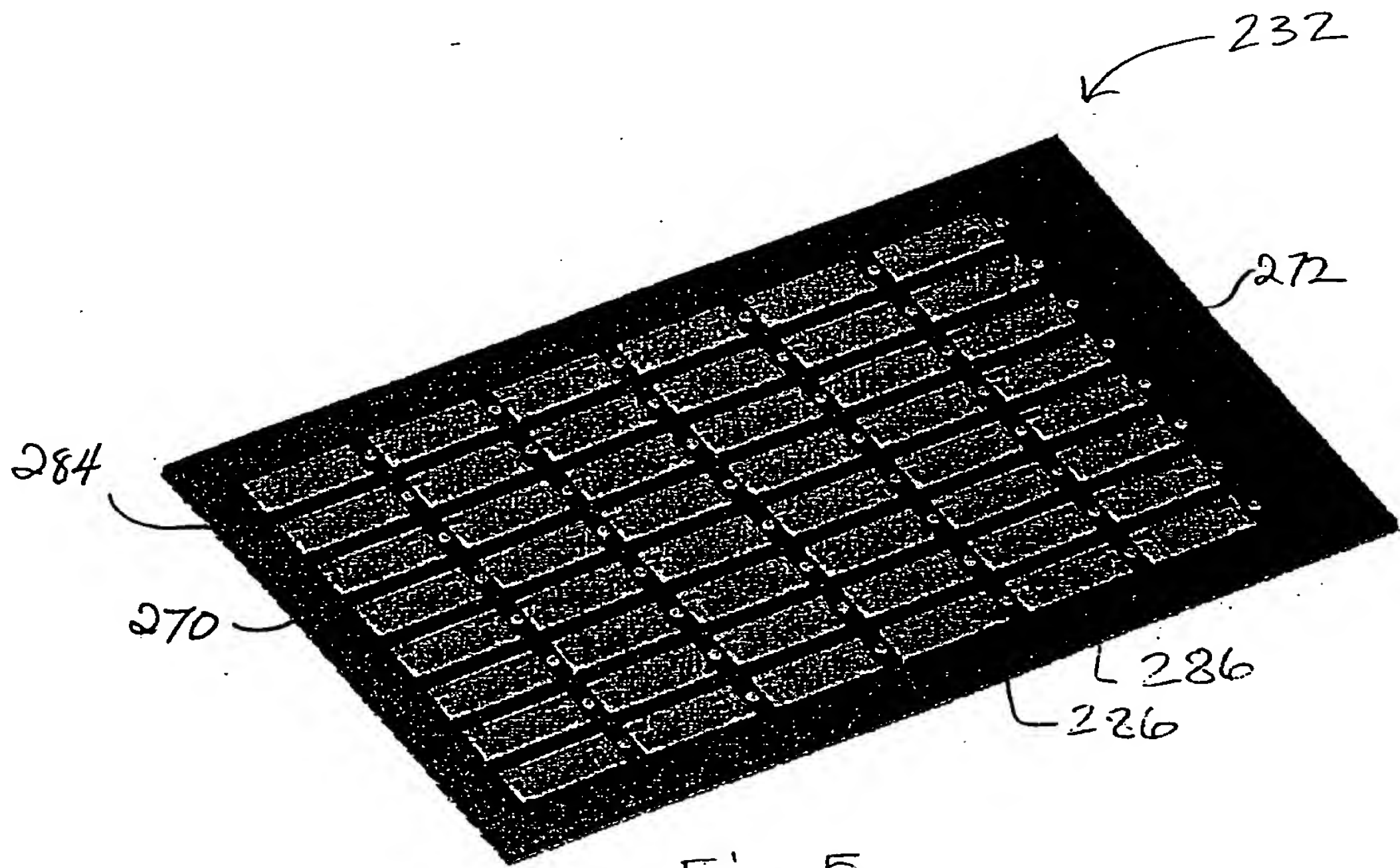


Fig. 5

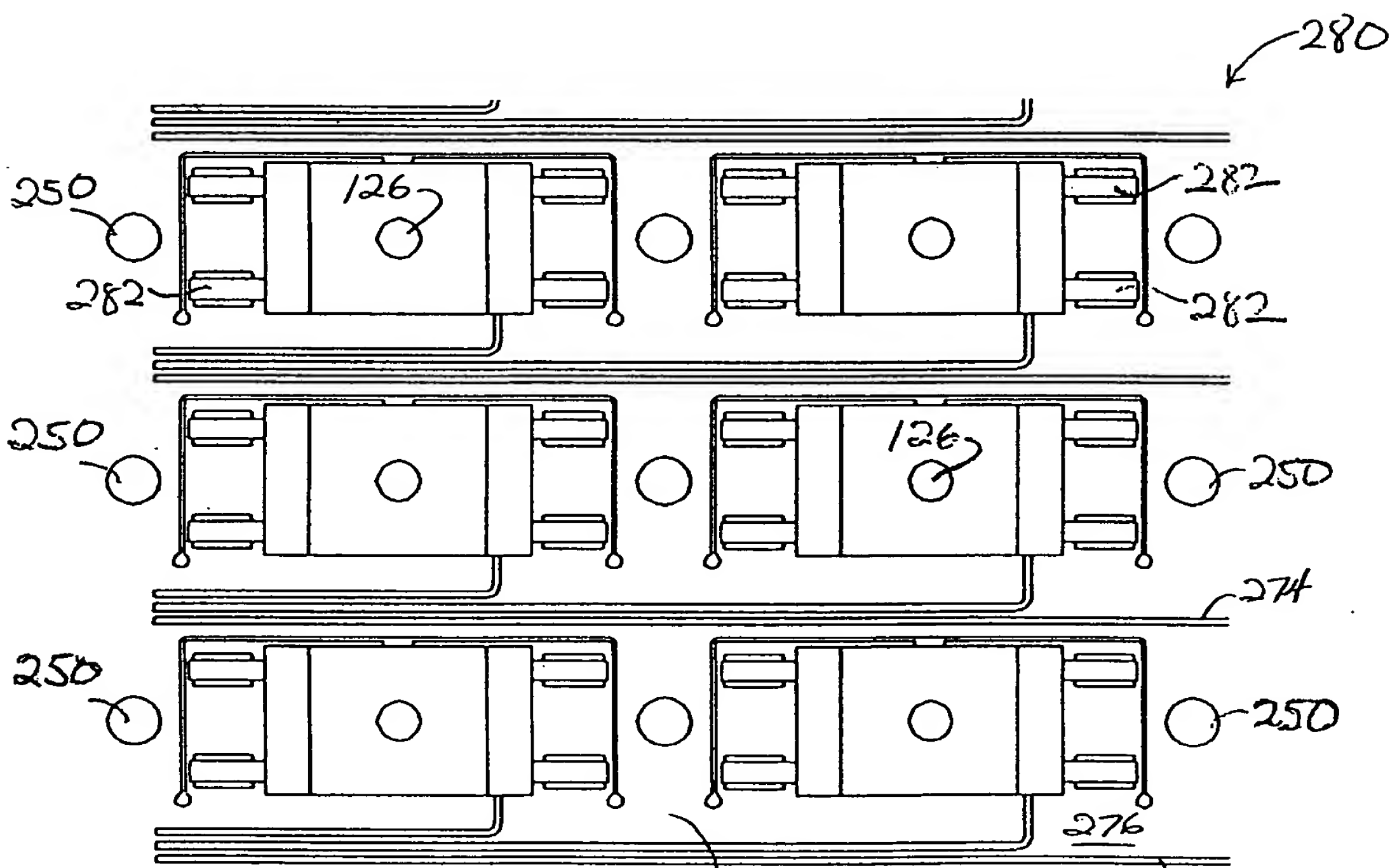


Fig. 6

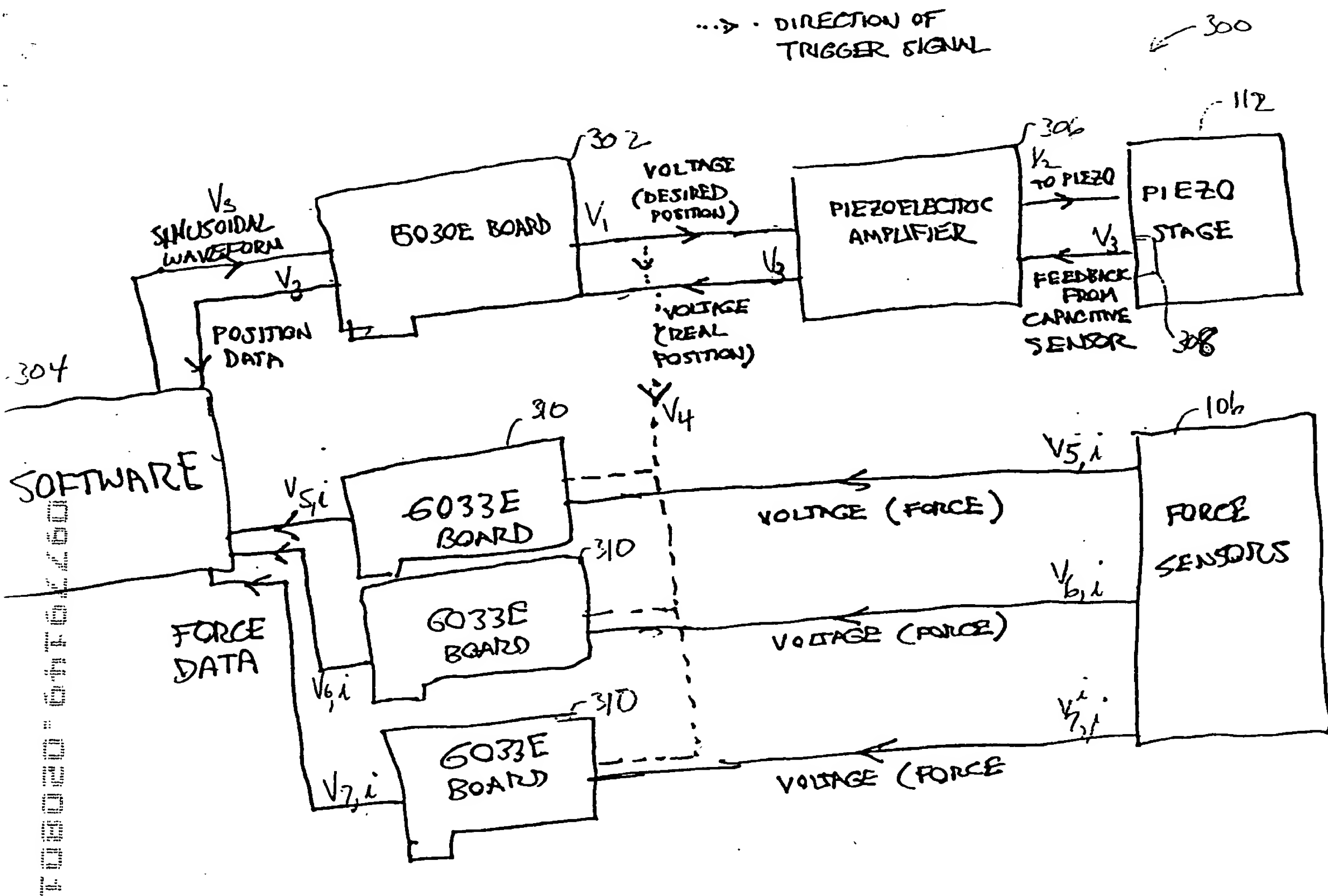


Fig. 7

FIG. 8

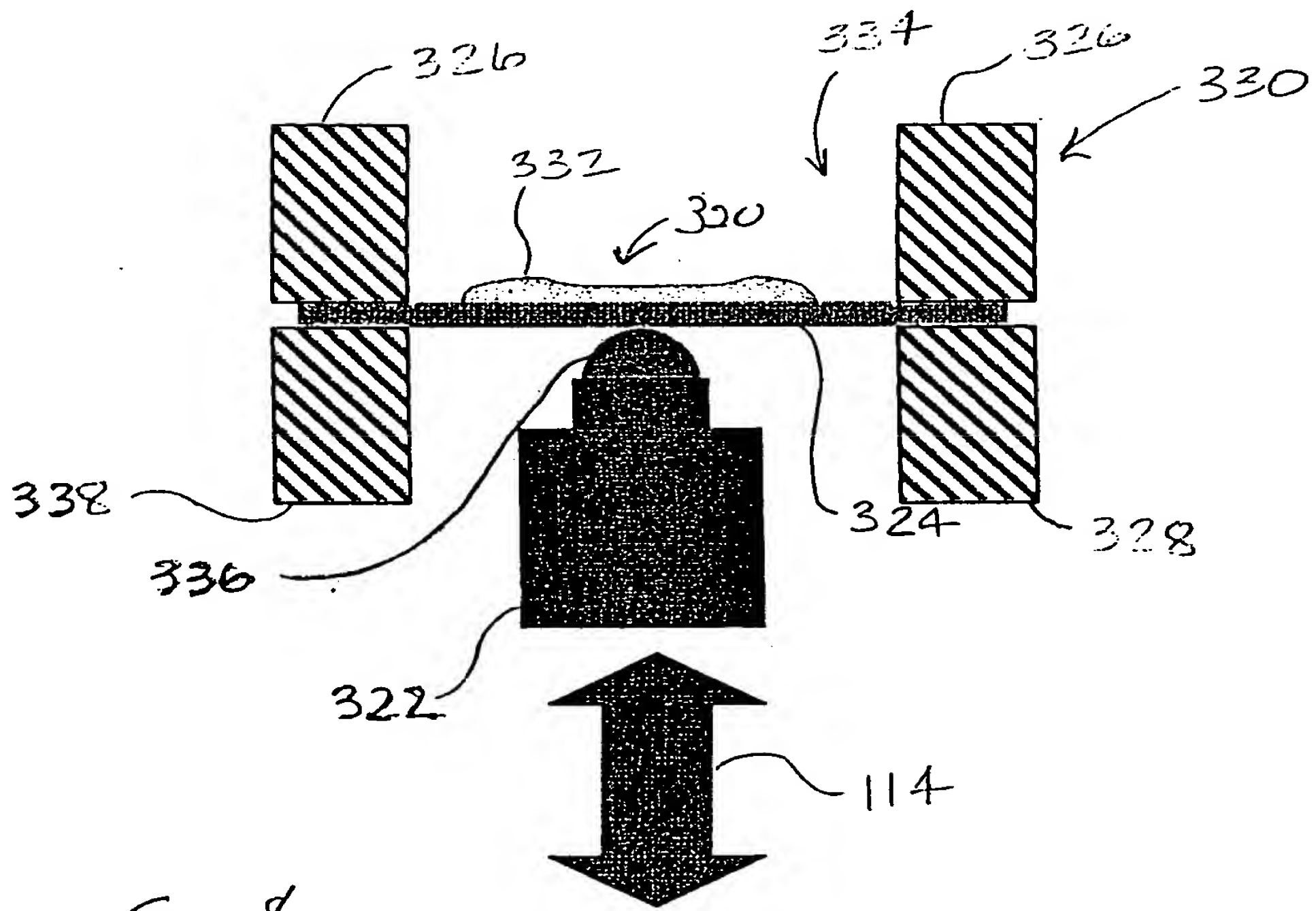


Fig. 8

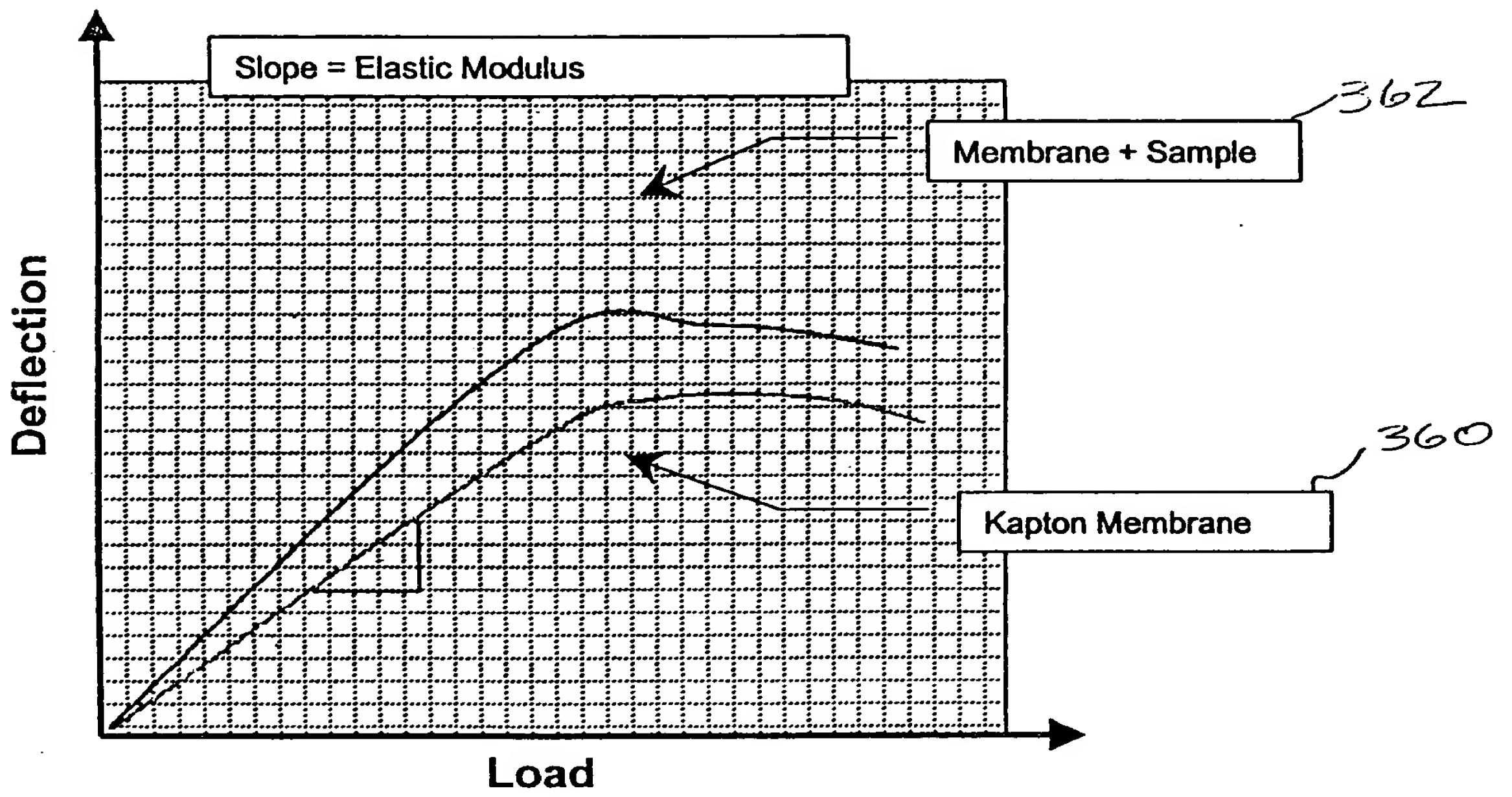


Fig. 9

THE UNIVERSITY OF CHICAGO

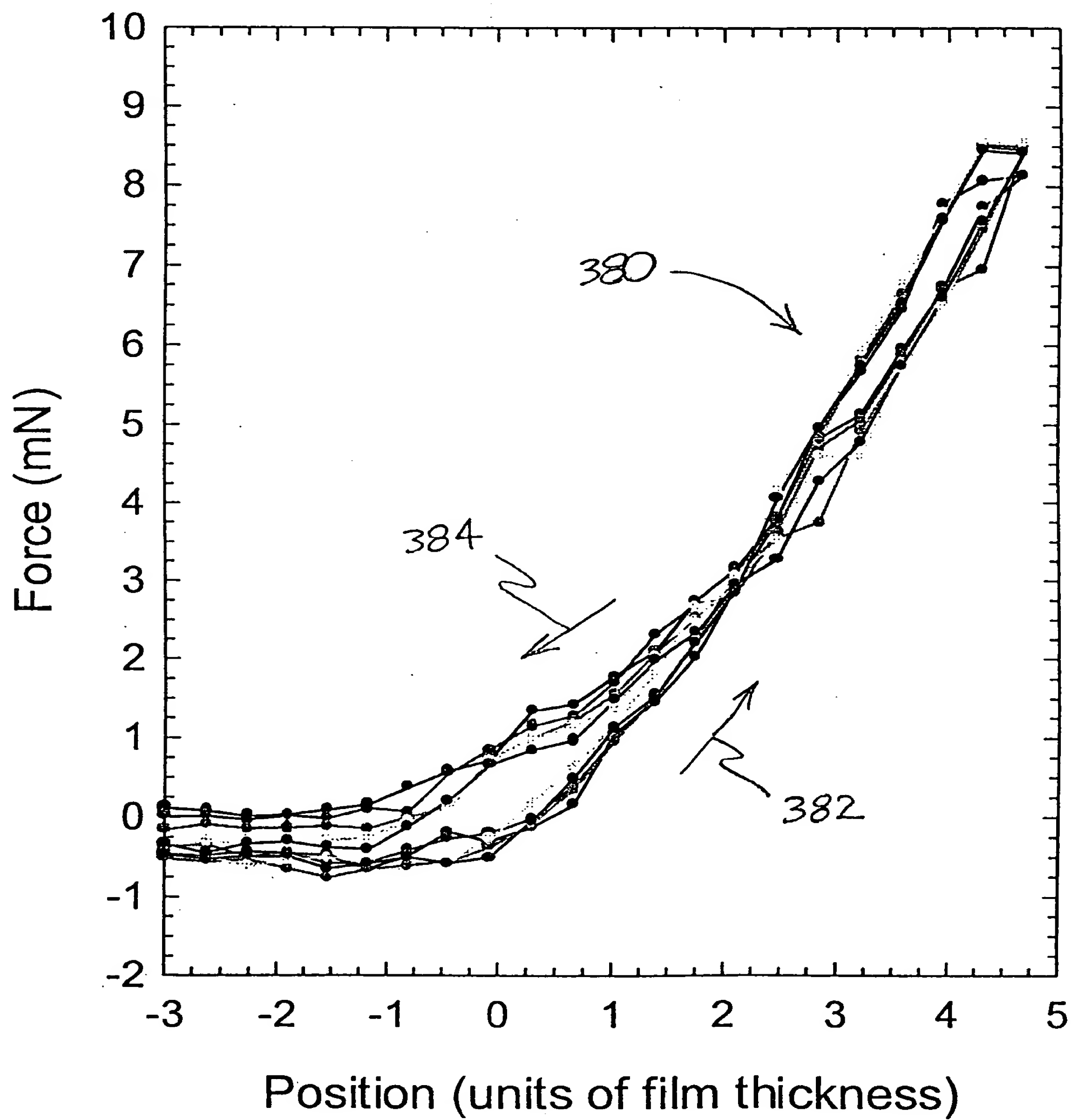


Fig-10

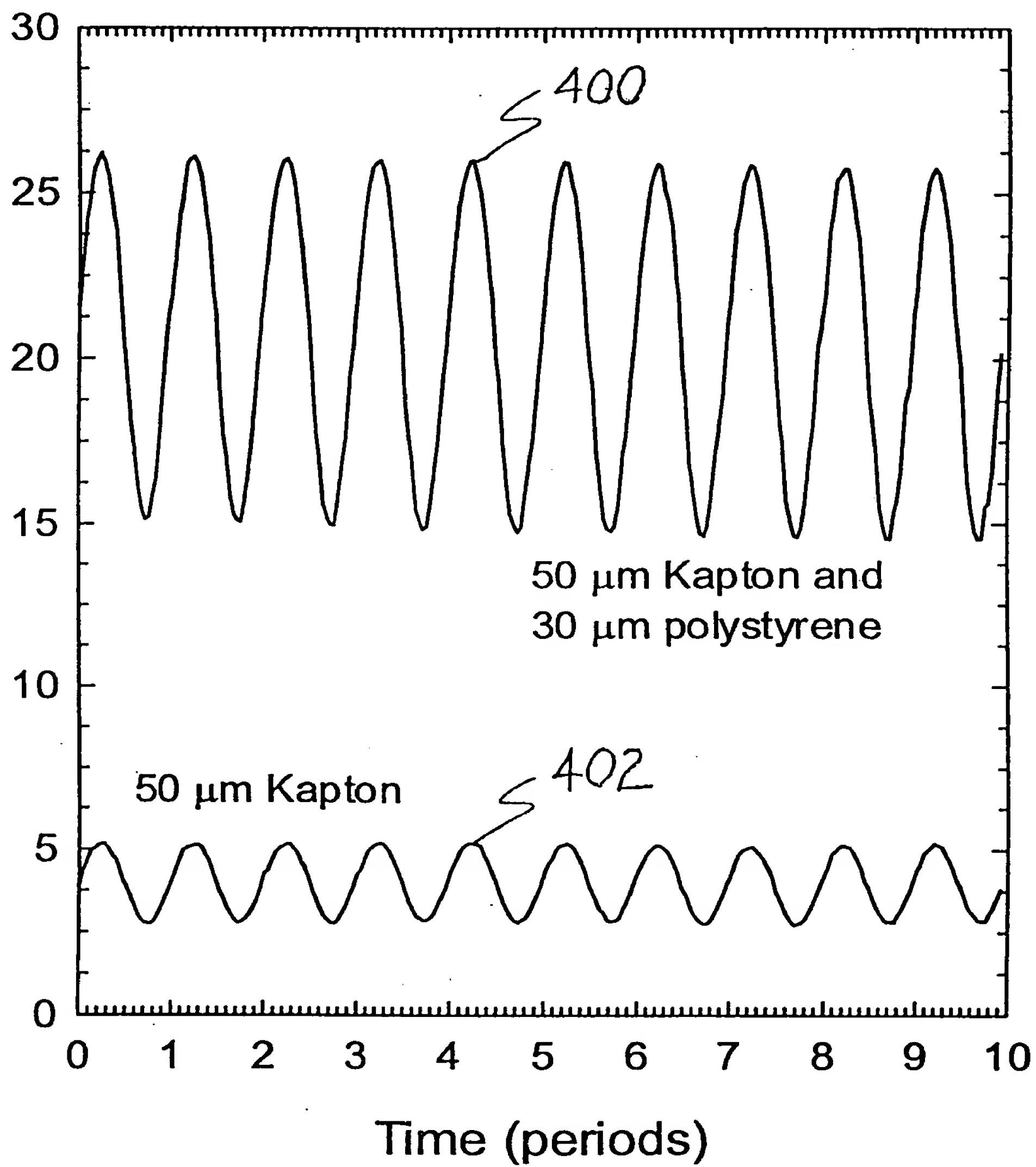
[illegible]

Fig. 11

TOP SECRET

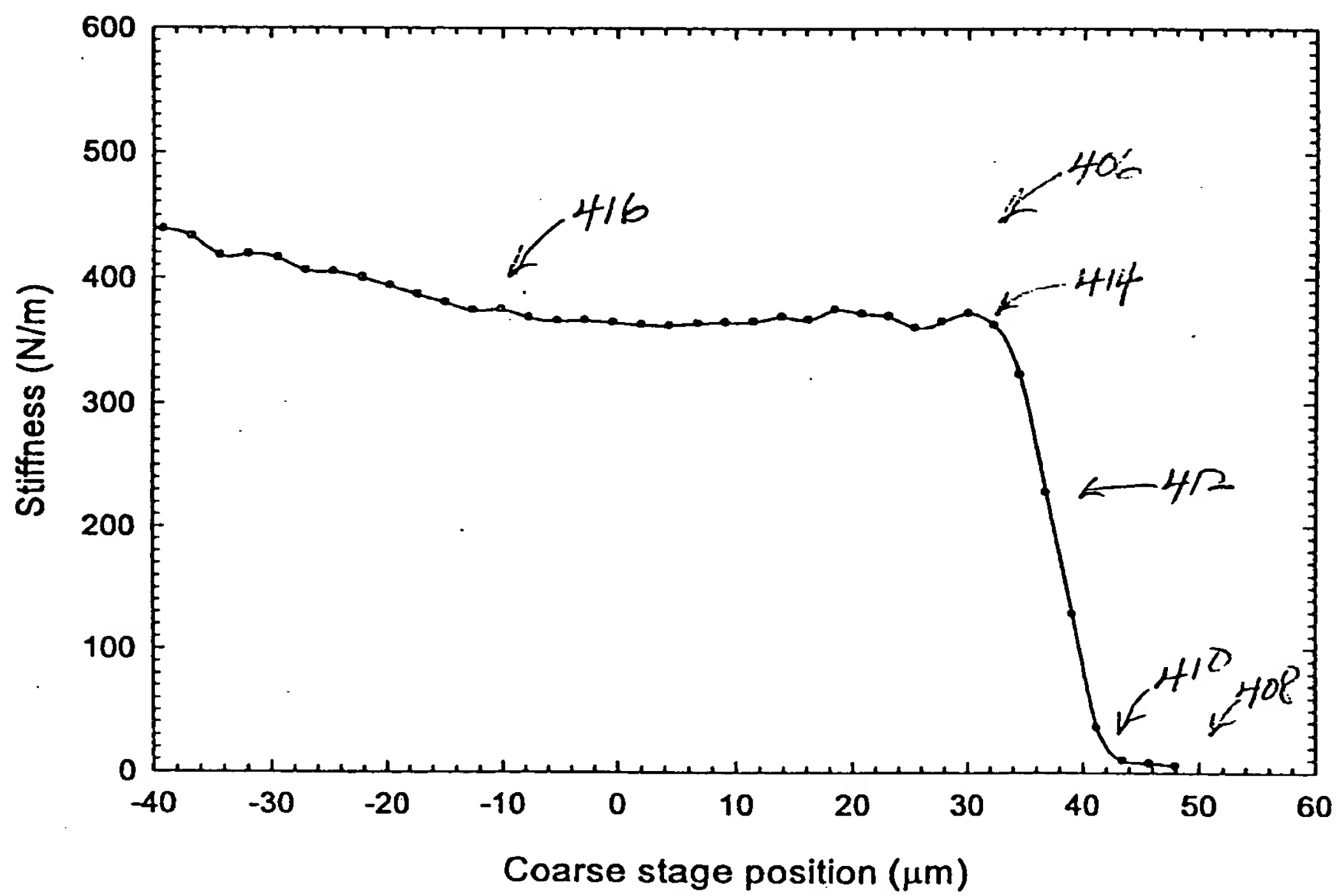


Fig. 12

A cross-sectional view of a multi-layered structure 420. The structure consists of a top layer 426, a middle layer 424, and a bottom layer 422. The middle layer 424 is composed of three vertical segments 428 separated by two vertical segments 432. A vertical double-headed arrow 430 indicates the thickness of the middle layer 424. The top layer 426 is shown with diagonal hatching, and the bottom layer 422 is shown with diagonal hatching. The middle layer 424 is shown with a cross-hatched pattern. The segments 428 and 432 are separated by vertical lines. The entire structure 420 is shown within a rectangular frame.

Fig. 13

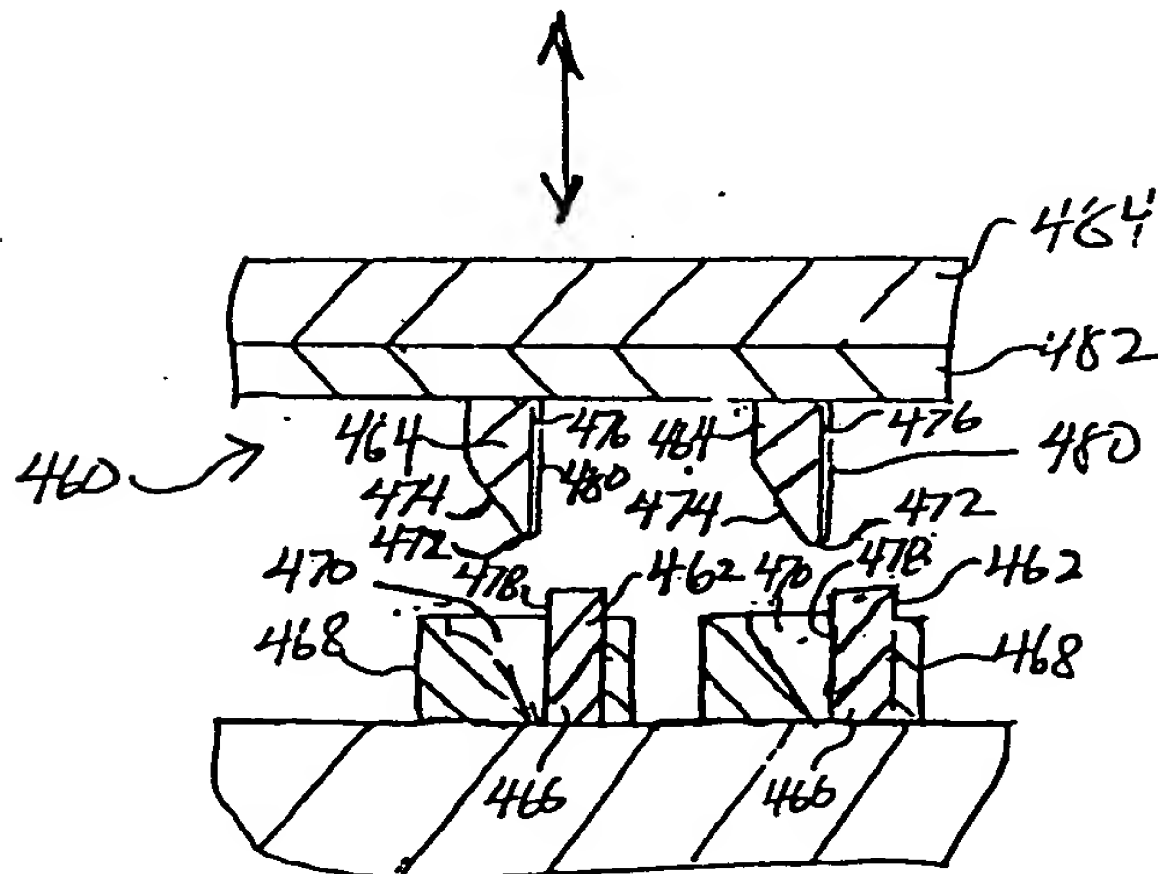


Fig. 14.

4.000000 0.000000 0.000000

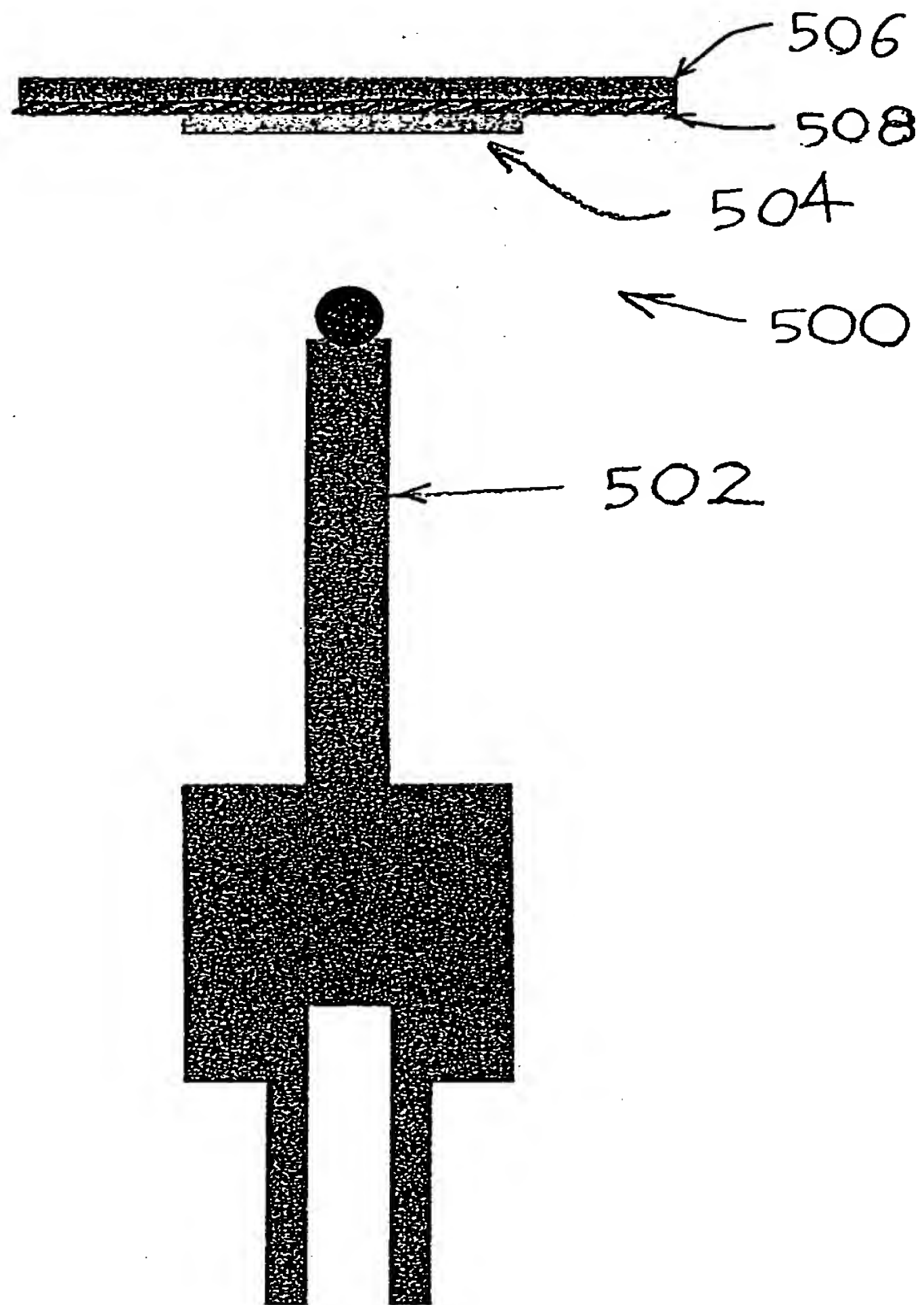


Fig. 15

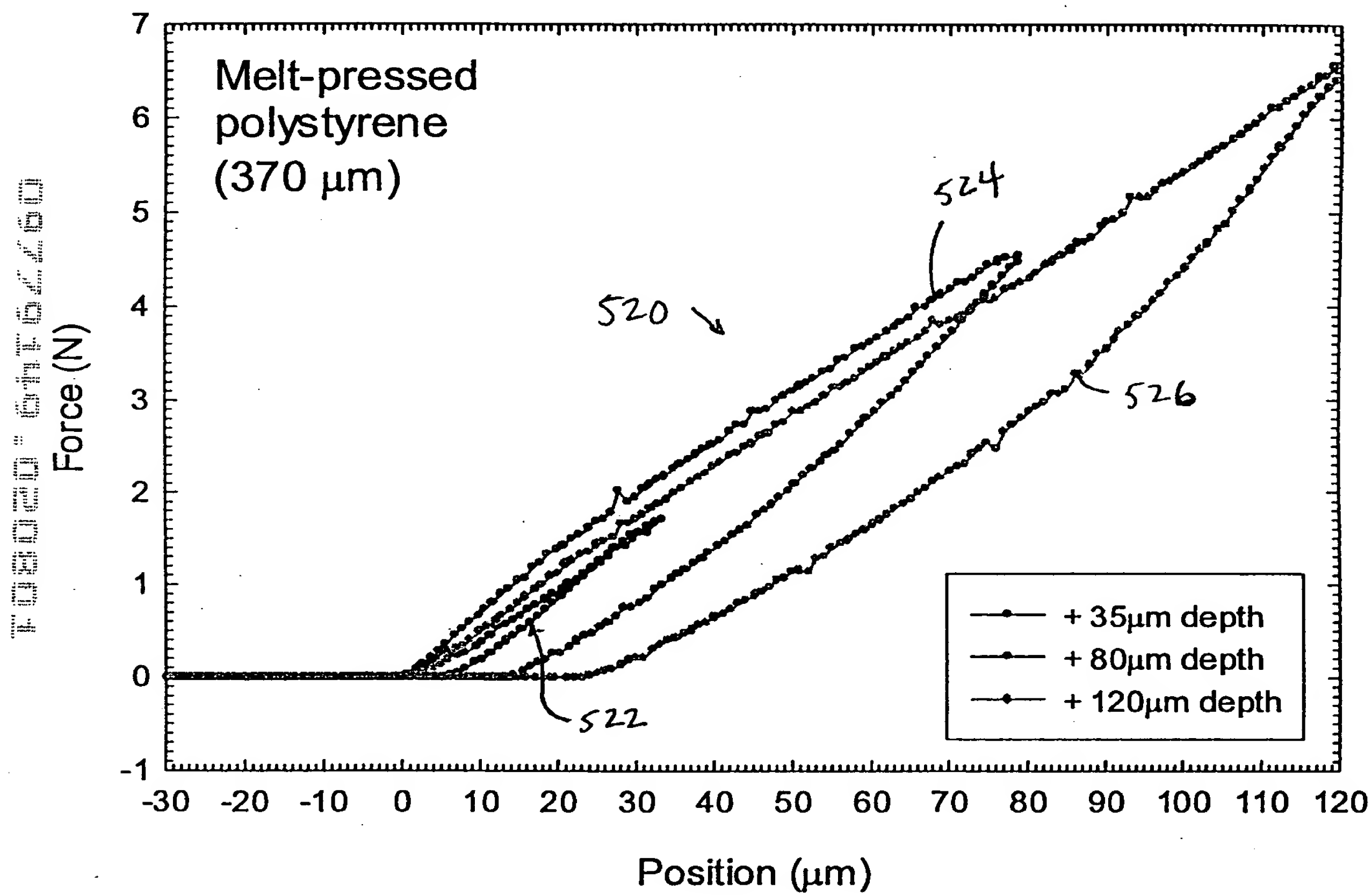


Fig. 16

This diagram shows a cross-sectional view of a mechanical assembly. At the top, a hatched layer is labeled 552. Below it is a dark, textured layer labeled 550. A horizontal section of this dark layer is labeled 548. A vertical stem, labeled 558, extends downwards from this section. The stem passes through a central opening in a larger, dark, textured structure labeled 554. The inner walls of this opening are labeled 544. The bottom of this opening is labeled 546. Below the opening, the stem continues through a larger, dark, textured block labeled 556. The entire assembly is labeled 542 with a large arrow pointing to the central vertical structure.

Fig. 17

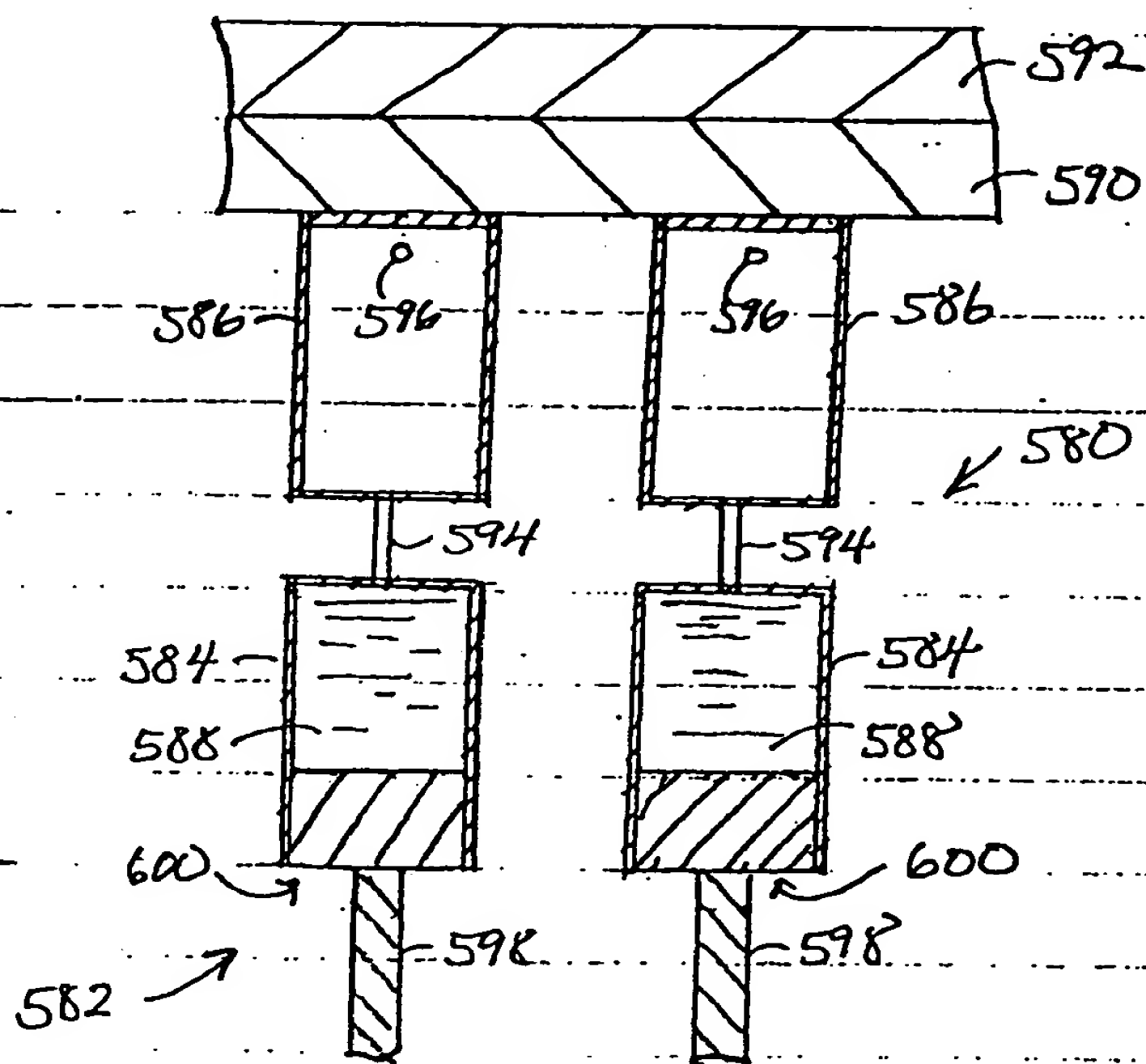


Fig. 18

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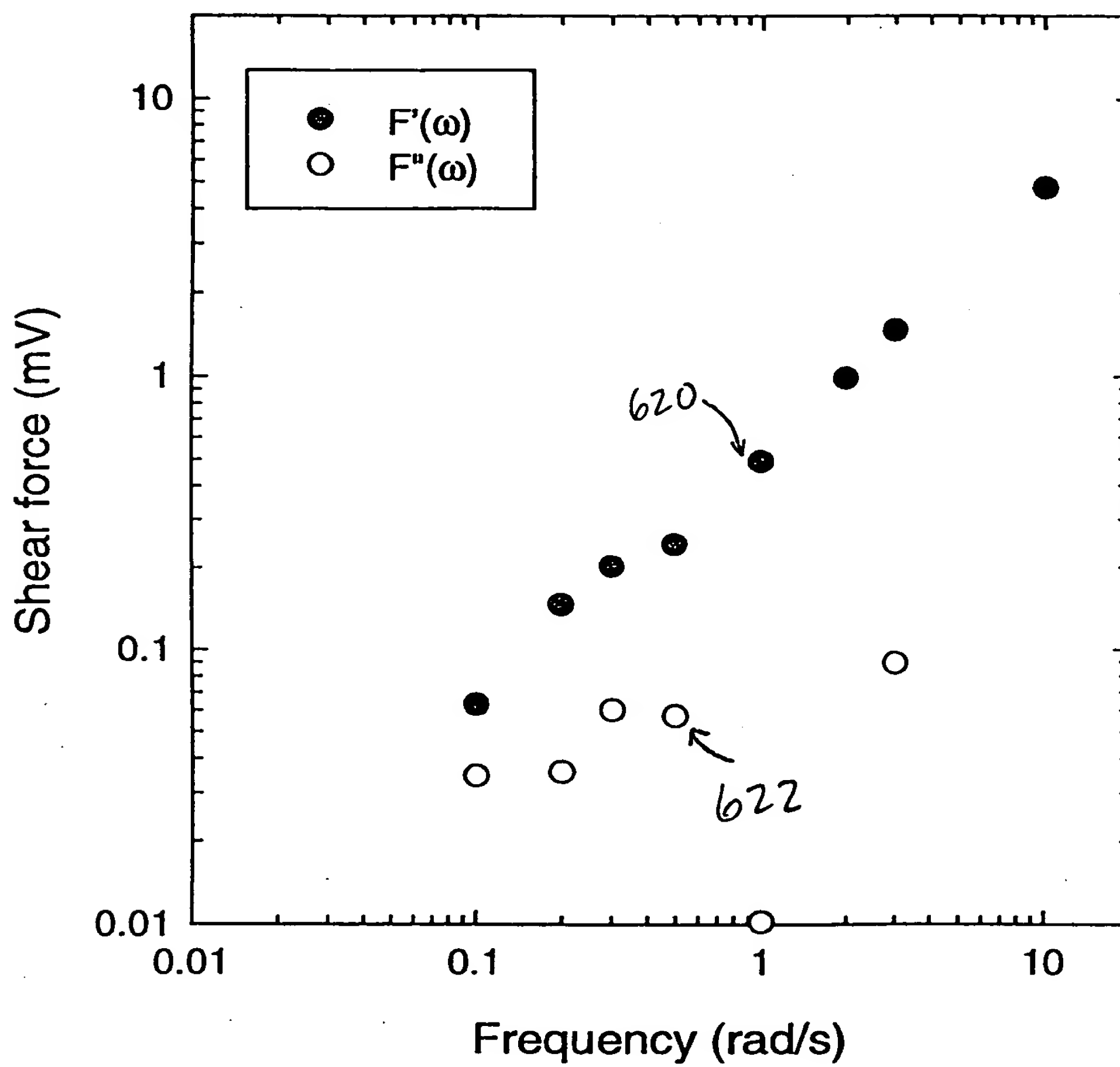


Fig. 19

Figure 1

Figure 1 consists of two panels, (a) and (b), showing histograms of the number of clusters per bin.

Panel (a) shows the distribution of cluster counts for different values of α . The x-axis is labeled "Number of Clusters" and ranges from 0 to 10. The y-axis is labeled "Frequency" and ranges from 0 to 10. The distributions are centered around 5 clusters.

Panel (b) shows the distribution of cluster counts for different values of β . The x-axis is labeled "Number of Clusters" and ranges from 0 to 10. The y-axis is labeled "Frequency" and ranges from 0 to 10. The distributions are centered around 5 clusters.

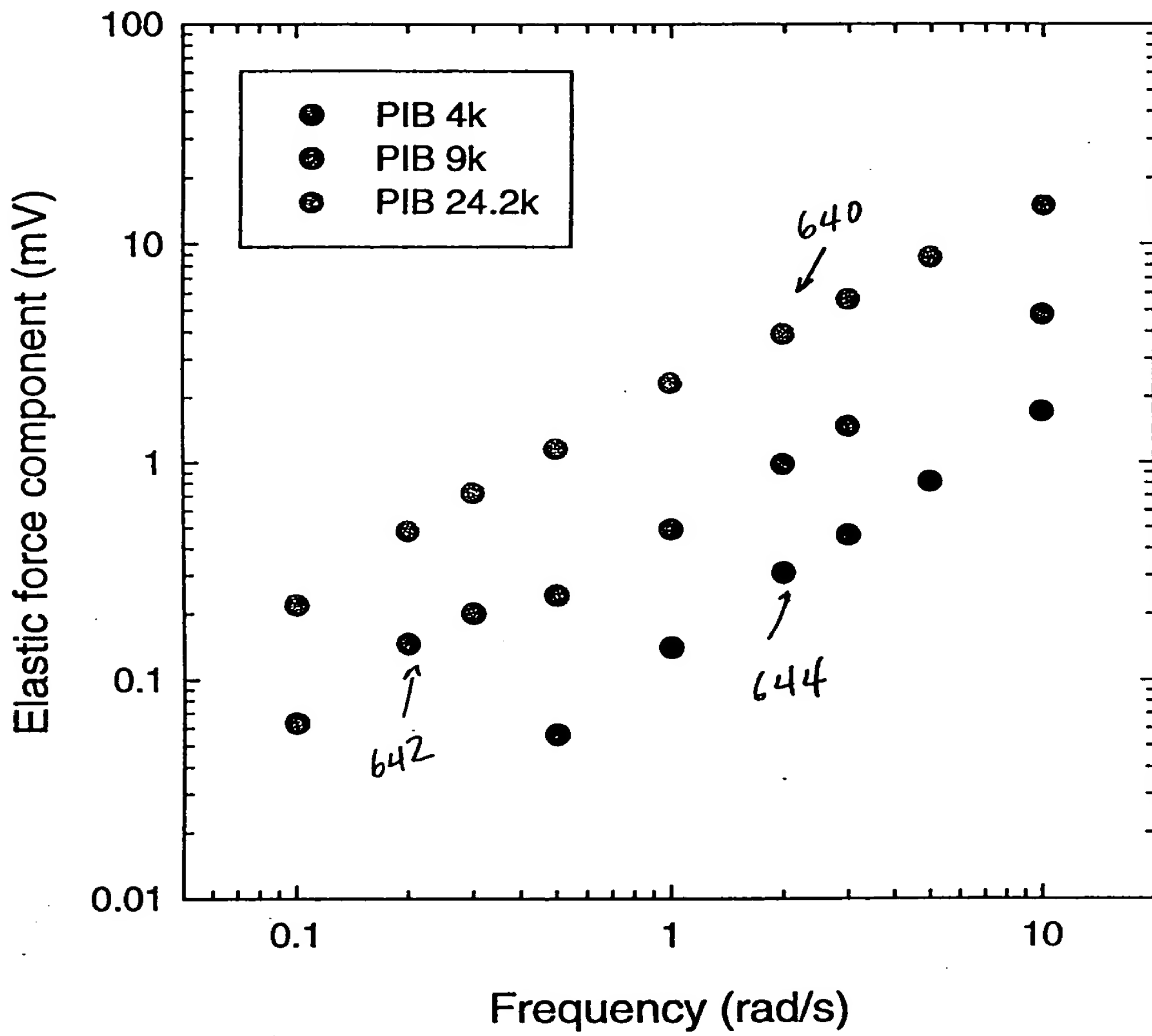


Fig. 20

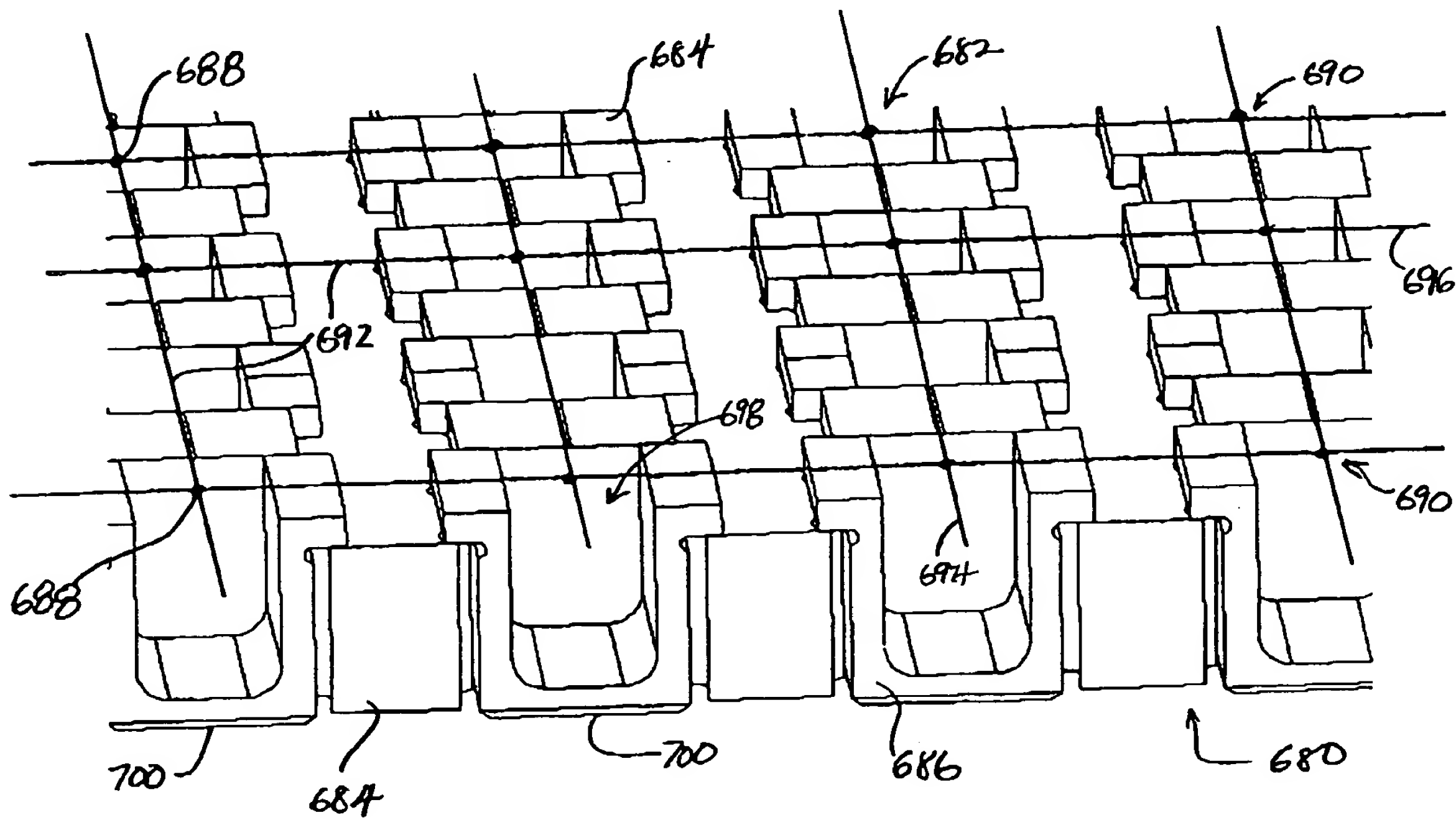


Fig. 24

524

Typical probe tack test data

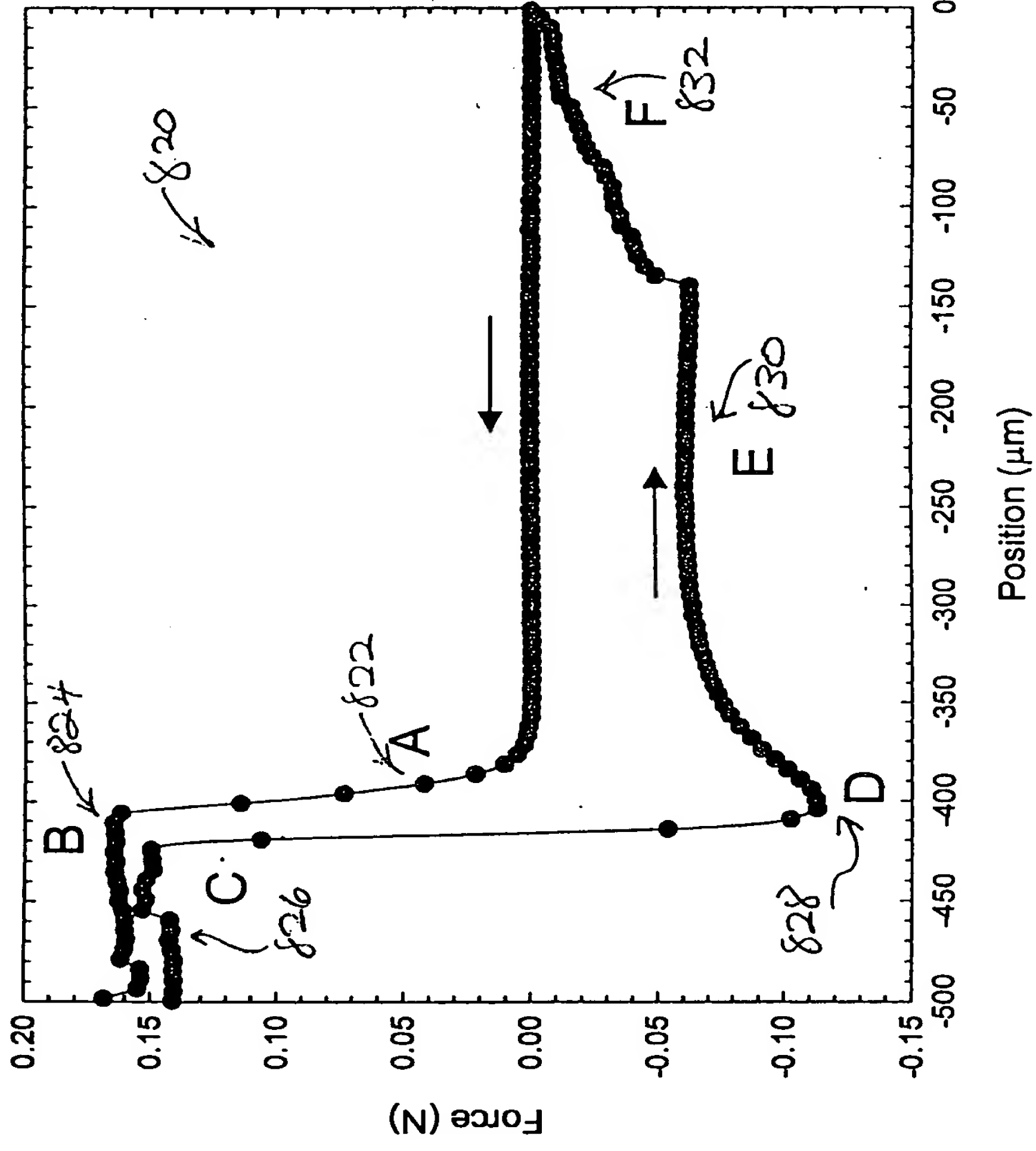


Fig-24

Typical solid modulus data

